

- 8.37 (a) Calculate the small-signal diffusion capacitance and diffusion resistance of a silicon pn junction diode biased at $I_{DQ} = 1.2 \text{ mA}$. Assume the minority carrier lifetimes are $0.5 \mu\text{s}$ in both the n and p regions. (b) Repeat part (a) for the case when the diode is biased at $I_{DQ} = 0.12 \text{ mA}$.

$$\text{Per (8.68), } r_d = \frac{V_t}{I_{DQ}}$$

$$\text{Per (8.105), } C_d = \frac{1}{2V_t} (I_{p0} \tau_{p0} + I_{n0} \tau_{n0})$$

$$\text{Per (8.104), } g_d = \frac{1}{V_t} (I_{p0} + I_{n0}) = \frac{I_{DQ}}{V_t} = \frac{1}{r_d}$$

$$\text{So, when } \tau_{n0} = \tau_{p0}, C_d = \frac{\tau_{n0}}{2r_d}$$

$$V_t = \frac{k_B T}{e} = \frac{8.617333 \times 10^{-5} \text{ eV/K} (300 \text{ K})}{e} = 0.025852 \text{ V}$$

$$\text{a) } r_d = \frac{0.025852}{1.2 \times 10^{-3}} \Rightarrow \underline{\underline{r_d = 21.543 \Omega}}$$

$$C_d = \frac{0.5 \times 10^{-6}}{2(21.543)} \Rightarrow \underline{\underline{C_d = 11.605 \text{ nF}}}$$

$$\text{b) } r_d = \frac{0.025852}{0.12 \times 10^{-3}} \Rightarrow \underline{\underline{r_d = 215.433 \Omega}}$$

$$C_d = \frac{0.5 \times 10^{-6}}{2(215.433)} \Rightarrow \underline{\underline{C_d = 1.1605 \text{ nF}}}$$